

CAT505

8-Bit Quad DACpot with RDY/BUSY and IND. Reference Inputs

FEATURES

- Output settings retained without power
- **Independent Reference Inputs**
- Output range includes both supply rails
- Programming voltage generated on-chip
- 4 independently addressable outputs
- Serial µP interface
- Single supply operation: 3-5 Volts

APPLICATIONS

- Automated product calibration.
- Remote control adjustment of equipment
- Offset, gain and zero adjustments in Self-Calibrating and Adaptive Control systems.
- Tamper-proof calibrations.

DESCRIPTION

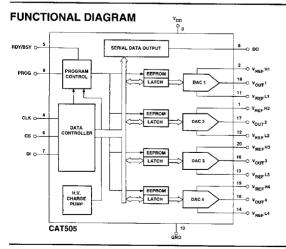
The CAT505 is a quad 8-Bit Memory DAC designed as an electronic replacement for mechanical potentiometers and trim pots. Intended for final calibration of products such as camcorders, fax machines and cellular telephones on automated high volume production lines and systems capable of self calibration, it is also well suited for applications were equipment requiring periodic adjustment is either difficult to access or located in a hazardous environment.

The CAT505 offers 4 independently programmable DACs each having its own reference inputs and each capable of rail to rail output swing. Output settings, stored non-volatile EEPROM memory, are not lost when the device is powered down and are automatically reinstated when power is returned. Each output can be dithered to test new output values without effecting the stored settings and stored settings can be read back without disturbing the DAC's output.

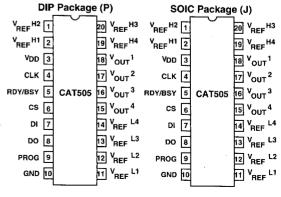
Control of the CAT505 is accomplished with a simple 3 wire serial interface. A Chip Select pin allows several CAT505s to share a common serial interface and communications back to the host controller is via a single serial data line thanks to the CAT505's Tri-Stated Data Output pin. A Rdy/Bsy output working in concert with an internal low voltage detector signals proper operation of EEPROM Erase/Write cycle.

The CAT505 operates from a single 3–5 volt power supply. The high voltage required for EEPROM Erase/Write operations is generated on-chip.

The CAT505 is available in the 0°C to 70°C Commercial and -40°C to +85°C Industrial operating temperature ranges and offered in 20-pin plastic DIP and Surface mount packages.



PIN CONFIGURATION



Symbol

ABSOLUTE MAXIMUM RATINGS

Supply Voltage*
V _{DD} to GND
V _{PP} to GND0.5V to +22V
Inputs
CLK to GND0.5V to V _{DD} +0.5V
CS to GND0.5V to V _{DD} +0.5V
DI to GND0.5V to V _{DD} +0.5V
RDY/BSY to GND0.5V to V _{DD} +0.5V
PROG to GND0.5V to V _{DD} +0.5V
V _{REF} H to GND0.5V to V _{DD} +0.5V
V _{REF} L to GND0.5V to V _{DD} +0.5V
Outputs
D ₀ to GND –0.5V to V _{DD} +0.5V
V _{OUT} 1 4 to GND0.5V to V _{DD} +0.5V

Operating Ambient Temperature

Min

Commercial ('C' suffix)	0°C to +70°C
Industrial ('l' suffix)	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature	65°C to +150°C
Lead Soldering (10 sec max)	

^{*}Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. Absolute Maximum Ratings are limited values applied individually while other parameters are within specified operating conditions, and functional operation at any of these conditions is NOT implied. Device performance and reliability may be impaired by exposure to absolute rating conditions for extended periods of time.

Max

RELIABILITY CHARACTERISTICS

Parameter

Symbol	Parameter	Min	Max	Units	Test Method
V _{ZAP} ⁽¹⁾	ESD Susceptibility	2000		Volts	MIL-STD-883, Test Method 3015
I _{LTH} ⁽¹⁾⁽²⁾	Latch-Up	100		mA JEDEC Standard 17	

NOTES: 1. This parameter is tested initially and after a design or process change that affects the parameter.

2. Latch-up protection is provided for stresses up to 100mA on address and data pins from -1V to V_{CC} + 1V.

DC ELECTRICAL CHARACTERISTICS: V_{DD} = +3V to +5V ±10%, V_{REF}H = V_{DD}, V_{REF}L = 0V, unless otherwise specified

Conditions

O y o .	1 414			- 7 17	1 114	-
	Resolution	,	8	_	_	Bits
Accuracy						
INL	Integral Linearity Error	I _{LOAD} = 250 nA, T _R = C	_	0.6	± 1	LSB
		T _R = 1		0.6	± 1	LSB
		$I_{LOAD} = 1 \mu A$, $T_R = C$	_	1.2	_	LSB
		$T_R = 1$	_	1.2	_	LSB
DNL	Differential Linearity Error	$I_{LOAD} = 250 \text{ nA}, T_R = C$	_	0.25	± 0.5	LSB
		T _R = I	_	0.25	± 0.5	LSB
		$I_{LOAD} = 1 \mu A$, $T_R = C$	_	0.5	_	LSB
		T _R = I	_	0.5		LSB
Logic Input	s					
l _{IH}	Input Leakage Current	$V_{IN} = V_{DD}$	_	_	10	μ A
I _{IL}	Input Leakage Current	V _{IN} = 0V			-10	μΑ
V _{IH}	High Level Input Voltage		2	_	V _{DD}	٧
V _{IL}	Low Level Input Voltage		0	_	0.8	٧
References						
V _{RH}	V _{REF} H Input Voltage Range		2.7	_	V _{DD}	٧
V _{RL}	V _{REF} L Input Voltage Range		GND		V _{DD} -2.7	٧
Z _{IN}	V _{REF} H-V _{REF} L Resistance		_	28K	_	Ω
ΔV _{IN} / R _{IN}	Input Resistance Match			± 0.5	± 1	%
Logic Outp	uts					
V _{OH}	High Level Output Voltage	I _{OH} = - 40 μA	V _{DD} -0.3	_	_	٧
V _{OL}	Low Level Output Voltage	$I_{OL} = 1 \text{ mA}, V_{DD} = +5V$	_	_	0.4	٧
		$I_{OL} = 0.4 \text{ mA}, V_{DD} = +3V$	_	-	0.4	٧

DC ELECTRICAL CHARACTERISTICS (Cont.):

 V_{DD} = +3V to +5V ±10%, $V_{REF}H$ = V_{DD} , $V_{REF}L = 0V$, unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Analog Ou	itput	<u> </u>	···			
FSO	Full-Scale Output Voltage	V _R = V _{REF} H - V _{REF} L	0.99 V _B	0.995 V _B	_	V
ZSO	Zero-Scale Output Voltage	V _R = V _{REF} H - V _{REF} L		0.005 V _B	0.10 V _B	
l _L	DAC Output Load Current				1	μА
R _{OUT}	DAC Output Impedance	$V_{DD} = V_{REF}H = +5V$	_		25K	$\frac{\rho}{\Omega}$
		$V_{DD} = V_{REF}H = +3V$	_		40K	Ω
PSSR	Power Supply Rejection	I _{LOAD} = 1 μA			1	LSB / V
Temperati	ıre					
TCo	V _{OUT} Temperature Coefficient	$V_{DD} = +5V, I_{LOAD} = 250nA$		_	200	μV/°C
		V _{REF} H= +5V, V _{REF} L = 0V			,	
TC _{REF}	Temperature Coefficient of V _{REF} Resistance	V _{REF} H to V _{REF} L	_	700	_	ppm / °C
Power Sup	oply					
IDD	Supply Current (Excludes V _{REF})	Normal Operating		18	50	μА
		Programming, V _{DD} = 5V	_	1200	2000	μА
		V _{DD} = 3V	_	600	1200	μА
		CS = 0	_	300	250	μА
V_{DD}	Operating Voltage Range		2.7		5.5	

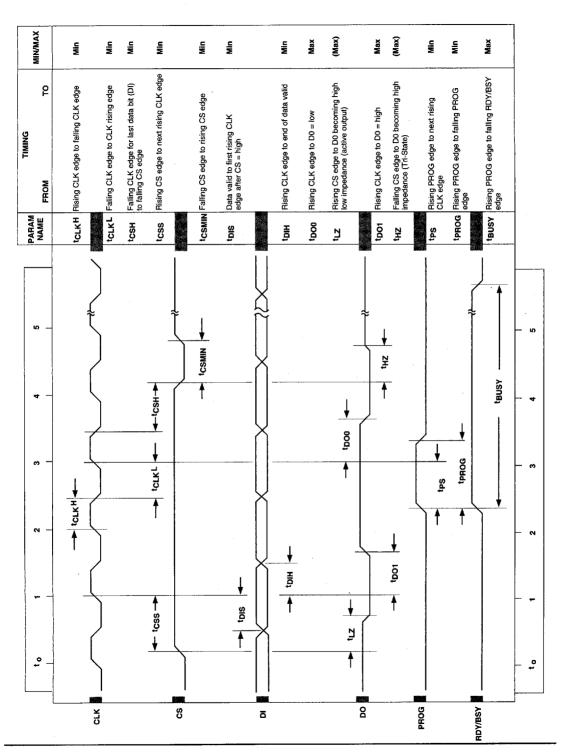
AC ELECTRICAL CHARACTERISTICS:

 V_{DD} = +3V to +5V ±10%, $V_{REF}H$ = V_{DD} , $V_{REF}L$ = 0V, unless otherwise specified

Symbol	Parameter Conditions		Min	Тур	Max	Units
Digital	· · · · · · · · · · · · · · · · · · ·					
tcsmin	Minimum CS Low Time		150		_	ns
tcss	CS Setup Time		100		_	ns
tcsH	CS Hold Time		0		_	ns
tois	DI Setup Time	C _L = 100 pF,	50		_	ns
t _{DIH}	DI Hold Time	see note 1	50			ns
t _{DO1}	Output Delay to 1	–			150	ns
t _{DO0}	Output Delay to 0				150	ns
t _{HZ}	Output Delay to High-Z			400	_	ns
t _{LZ}	Output Delay to Low-Z			400		ns
t _{BUSY}	Erase/Write Cycle Time			3.3	5	ms
tps	PROG Setup Time		150			ns
t _{PROG}	Minimum Pulse Width		500			ns
t _{CLK} H	Minimum CLK High Time		500			ns
t _{CLK} L	Minimum CLK Low Time		300			ns
fc	Clock Frequency		DC		1	MHz
nalog				L	l	1 3
t _{DS}	DAC Settling Time to 1 LSB	$C_{LOAD} = 10 \text{ pF}, V_{DD} = +5V$	_	3	10	μs
	·	C _{LOAD} = 10 pF, V _{DD} = +3V	_	6	10	μѕ
in Capac	itance			l	L	
CIN	Input Capacitance	V _{IN} = 0V, f = 1 MHz, ⁽²⁾		8		pF
Cout	Output Capacitance	V _{OUT} = 0V, f = 1 MHz, (2)		6		pF

^{2.} These parameters are periodically sampled and are not 100% tested.

A. C. TIMING DIAGRAM



PIN DESCRIPTION

Pin	Name	Function
1	V _{REF} H2	Maximum DAC 2 output voltage
2	V _{REF} H1	Maximum DAC 1 output voltage
3	V _{DD}	Power supply positive
4	CLK	Clock input pin
5	RDY/BSY	Ready/Busy output
6	CS	Chip select
7	DI	Serial data input pin
8	DO	Serial data output pin
9	PROG	EEPROM Programming Enable
		Input
10	GND	Power supply ground
11	V _{REF} L1	Minimum DAC 1 output voltage
12	V _{REF} L2	Minimum DAC 2 output voltage
13	V _{REF} L3	Minimum DAC 3 output voltage
14	V _{REF} L4	Minimum DAC 4 output voltage
15	V _{OUT} 4	DAC 4 output
16	V _{OUT} 3	DAC 3 output
17	V _{OUT} 2	DAC 2 output
18	V _{OUT} 1	DAC 1 output
19	V _{REF} H4	Maximum DAC 4 output voltage
20	V _{REF} H3	Maximum DAC 3 output voltage

DAC addressing is as follows:

DAC OUTPUT	A0	A1
V _{OUT} 1	0	0
V _{OUT} 2	1	0
V _{OUT} 3	0	1
V _{OUT} 4	1	1

DEVICE OPERATION

The CAT505 is a quad 8-bit Digital to Analog Converter (DAC) whose outputs can be programmed to any one of 256 individual voltage steps. Once programmed, these output settings are retained in non-volatile EEPROM memory and will not be lost when power is removed from the chip. Upon power up the DACs return to the settings stored in EEPROM memory. Each DAC can be written to and read from independently without effecting the output voltage during the read or write cycle. Each output can also be adjusted without altering the stored output setting, which is useful for testing new output settings before storing them in memory.

DIGITAL INTERFACE

The CAT505 employs a standard 3 wire serial control interface consisting of Clock (CLK), Chip Select (CS) and Data In (DI) inputs. For all operations, address and data are shifted in LSB first. In addition, all digital data must be preceded by a logic "1" as a start bit. The DAC address and data are clocked into the DI pin on the clock's rising edge. When sending multiple blocks of information a minimum of two clock cycles is required between the last block sent and the next start bit.

Multiple devices may share a common input data line by selectively activating the CS control of the desired IC. Data Outputs (DO) can also share a common line because the DO pin is Tri-Stated and returns to a high impedance when not in use.

CHIP SELECT

Chip Select (CS) enables and disables the CAT505's read and write operations. When CS is high data may be read to or from the chip, and the Data Output (DO) pin is active. Data loaded into the DAC control registers will remain in effect until CS goes low. Bringing CS to a logic low returns all DAC outputs to the settings stored in EEPROM memory and switches DO to its high impedance Tri-State mode.

Because CS functions like a reset the CS pin has been desensitized with a 30 ns to 90 ns filter circuit to prevent noise spikes from causing unwanted resets and the loss of volatile data.

CLOCK

The CAT505's clock controls both data flow in and out of the IC and EEPROM memory cell programming. Serial data is shifted into the DI pin and out of the DO pin on the clock's rising edge. While it is not necessary for the clock to be running between data transfers, the clock must be operating in order to write to EEPROM memory, even though the data being saved may already be resident in the DAC control register.

No clock is necessary upon system power-up. The CAT505's internal power-on reset circuitry loads data from EEPROM to the DACs without using the external clock.

As data transfers are edge triggered clean clock transitions are necessary to avoid falsely clocking data into the control registers. Standard CMOS and TTL logic families work well in this regard and it is recommended that any mechanical switches used for breadboarding or device evaluation purposes be debounced by a flip-flop or other suitable debouncing circuit.

VREF

V_{REF}, the voltage applied between pins V_{REF}H &V_{REF}L, sets the DAC's Zero to Full Scale output range where V_{REF}L = Zero and V_{REF}H = Full Scale. V_{REF} can span the full power supply range or just a fraction of it. In typical applications V_{REF}H &V_{REF}L are connected across the power supply rails. When using less than the full supply voltage be mindfull of the limits placed on V_{REF}H and V_{REF}L as specified in the **References** section of **DC Electrical Characteristics.**

READY/BUSY

When saving data to non-volatile EEPROM memory, the Ready/Busy ouput (RDY/BSY) signals the start and duration of the EEPROM erase/write cycle. Upon receiving a command to store data (PROG goes high) RDY/BSY goes low and remains low until the programming cycle is complete. During this time the CAT505 will ignore any data appearing at DI and no data will be output on DO.

RDY/BSY is internally ANDed with a low voltage detector circuit monitoring V_{DD} . If V_{DD} is below the minimum value required for EEPROM programming, RDY/BSY will remain high following the program command indicating a failure to record the desired data in non-volatile memory.

DATA OUTPUT

Data is output serially by the CAT505, LSB first, via the Data Out (DO) pin following the reception of a start bit and two address bits by the Data Input (DI). DO becomes active whenever CS goes high and resumes

its high impedance Tri-State mode when CS returns low. Tri-Stating the DO pin allows several 505s to share a single serial data line and simplifies interfacing multiple 505s to a microprocessor.

WRITING TO MEMORY

Programming the CAT505's EEPROM memory is accomplished through the control signals: Chip Select (CS) and Program (PROG). With CS high, a start bit followed by a two bit DAC address and eight data bits are clocked into the DAC control register via the DI pin. Data enters on the clock's rising edge. The DAC output changes to its new setting on the clock cycle following D7, the last data bit.

Programming is accomplished by bringing PROG high sometime after the start bit and at least 150 ns prior to the rising edge of the clock cycle immediately following the D7 bit. Two clock cycles after the D7 bit the DAC control register will be ready to receive the next set of address and data bits. The clock must be kept running throughout the programming cycle. Internal control circuitry takes care of generating and ramping up the programming voltage for data transfer to the EEPROM cells. The CAT505's EEPROM memory cells will endure over 100,000 write cycles and will retain data for a minimum of 20 years without being refreshed.

READING DATA

Each time data is transferred into a DAC control register currently held data is shifted out via the DI pin, thus in every data transaction a read cycle occurs. Note, however, that the reading process is destructive. Data must be removed from the register in order to be read. Figure 2 depicts a Read Only cycle in which no change occurs in the DAC's output. This feature allows μPs to poll DACs for their current setting without disturbing the output voltage but it assumes that the setting being read is also stored in EEPROM so that it can be restored at the end of the read cycle. In Figure 2 CS returns low before the 13th clock cycle completes. In doing so the EEPROM's



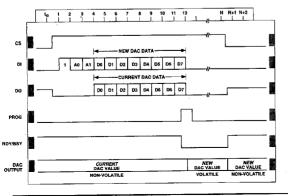
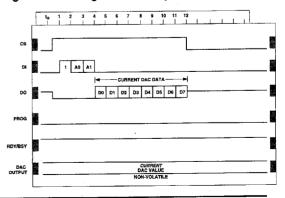


Figure 2. Reading from Memory



setting is reloaded into the DAC control register. Since this value is the same as that which had been there previously no change in the DAC's output is noticed. Had the value held in the control register been different from that stored in EEPROM then a change would occur at the read cycle's conclusion.

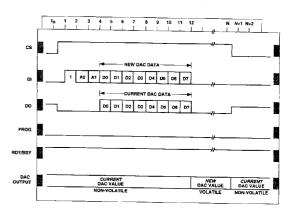
TEMPORARILY CHANGE OUTPUT

The CAT505 allows temporary changes in DAC's output to be made without disturbing the settings retained in EEPROM memory. This feature is particularly useful when testing for a new output setting and allows for user adjustment of preset or default values without losing the original factory settings.

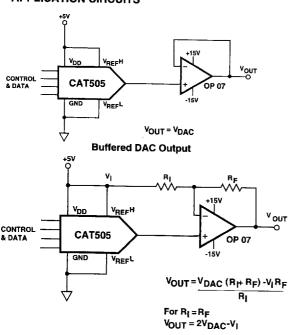
Figure 3 shows the control and data signals needed to effect a temporary output change. DAC settings may be changed as many times as required and can be made to any of the four DACs in any order or sequence. The temporary setting(s) remain in effect long as CS remains high. When CS returns low all four DACs will return to the output values stored in EEPROM memory.

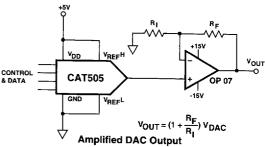
When it is desired to save a new setting acquired using this feature, the new value must be reloaded into the DAC control register prior to programming. This is because the CAT505's internal control circuitry discards from the programming register the new data two clock cycles after receiving it if no PROG signal is received.

Figure 3. Temporary Change in Output



APPLICATION CIRCUITS

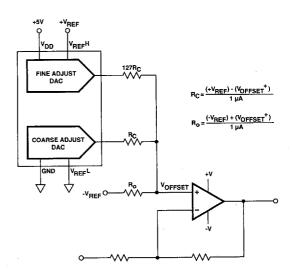




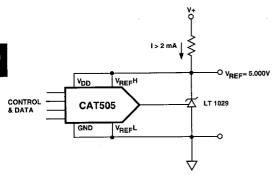
		•	
DAC	INPUT	DAC OUTPUT	ANALOG OUTPUT
		VDAC= CODE (VFS-VZERO)+VZERO	301101
		V _{FS} = 0.99 V _{REF}	V _{REF} = 5V
MSB	LSB	VZERO = 0.01 VREF	R _I =R _F
1111	1111	255 (.98 V _{REF}) + .01 V _{REF} = .990 V _{REF}	V _{OUT} = +4.90V
1000	0000	128 (.98 V _{REF}) + .01 V _{REF} ≈ .502 V _{REF}	V _{OUT} = +0.02V
0111	1111	127 255 (.98 V _{REF}) + .01 V _{REF} = .498 V _{REF}	V _{OUT} = -0.02V
0000	0001	1 (.98 V _{REF}) + .01 V _{REF} = .014 V _{REF}	V _{OUT} = -4.86V
0000	0000	0 (.98 V _{REF}) + .01 V _{REF} = .010 V _{REF}	V _{OUT} = -4.90V

Bipolar DAC Output

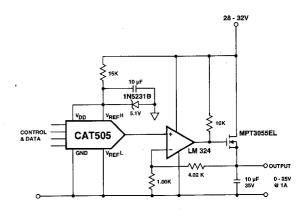
Coarse-Fine Offset Control by Averaging DAC Outputs for Single Power Supply Systems



Coarse-Fine Offset Control by Averaging DAC Outputs for Dual Power Supply Systems

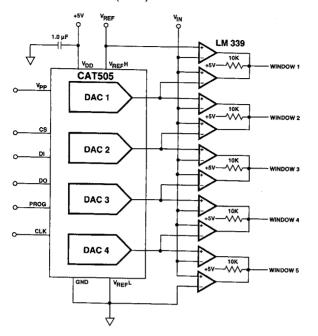


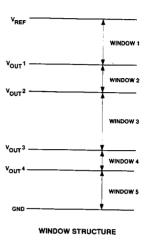
Digitally Trimmed Voltage Reference



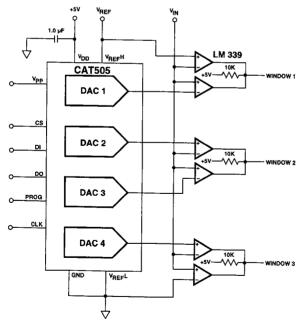
Digitally Controlled Voltage Reference

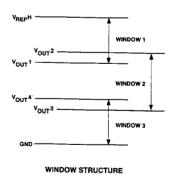
APPLICATION CIRCUITS (Cont.)





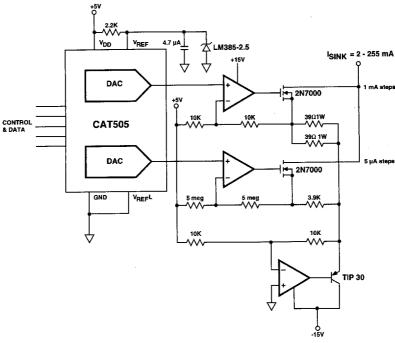
Staircase Window Comparator



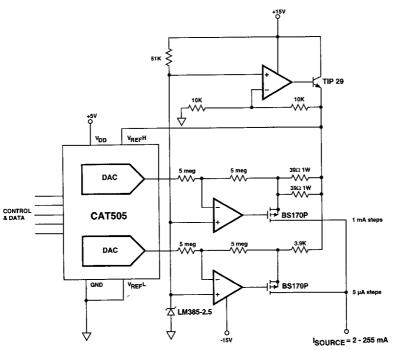


Overlapping Window Comparator

APPLICATION CIRCUITS (Cont.)

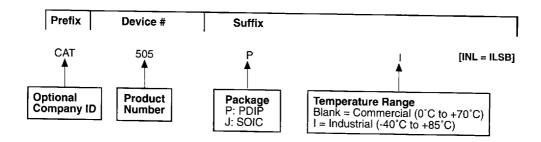


Current Sink with 4 Decades of Resolution



Current Source with 4 Decades of Resolution

ORDERING INFORMATION



Notes:

(1) The device used in the above example is a CAT505PI (Plastic DIP, Industrial Temperature)